Notice of References Cited	Application/Control No. 10/664,641	Applicant(s)/Patent Under Reexamination FUKUDA ET AL.	
Notice of Neterences Cheu	Examiner	Art Unit	
	Vincent E. Kovalick	2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,540,361	04-2003	Hayashi, Kohtaro	353/31
*	В	US-6,407,860	06-2002	Funazaki et al.	359/457
*	С	US-5,398,086	03-1995	Nakano et al.	353/31
*	D	US-4,375,739	03-1983	Machida et al.	451/163
*	E	US-2002/0196563	12-2002	Itoh, Nobuki	359/741
. **	F	US-2002/0150333	10-2002	Reed et al.	385/34
*	G	US-2001/0048493	12-2001	Swanson et al.	349/62
,	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-		·	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
L	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.